

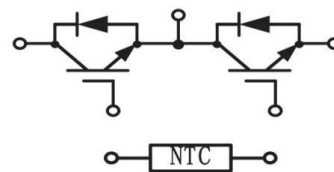
PRODUCT FEATURES

- IGBT CHIP(Trench+FS)
- Low saturation voltage and positive temperature coefficient
- Fast switching and short tail current
- Free wheeling diodes with fast and soft reverse recovery
- Temperature sense included
- 10 μ s Short Circuit Withstand



APPLICATIONS

- Motor Drives
- Power Charging Equipment
- Solar Power
- Electric Vehicle



IGBT

ABSOLUTE MAXIMUM RATINGS($T_C = 25^\circ C$ unless otherwise specified)

Symbol	Parameter/ Test Conditions	Values	Unit
V_{CES}	Collector Emitter Voltage	1200	V
V_{GES}	Gate Emitter Voltage	± 20	
I_c	DC Collector Current	450	A
I_{CM}	Repetitive Peak Collector Current	900	
P_{tot}	Power Dissipation Per IGBT	2.8	kW

Test Conditions: $T_J = 25^\circ C$, $T_C = 100^\circ C$, $T_{Jmax} = 175^\circ C$, $t_p = 1\text{ms}$

Diode

ABSOLUTE MAXIMUM RATINGS($T_C = 25^\circ C$ unless otherwise specified)

Symbol	Parameter/ Test Conditions	Values	Unit
V_{RRM}	Repetitive Reverse Voltage	1200	V
$I_{F(AV)}$	Average Forward Current	450	A
I_{FRM}	Repetitive Peak Forward Current	900	
I^2t		27.2	kA ² s

Test Conditions: $T_J = 150^\circ C$, $t = 10\text{ms}$, $V_R = 0\text{V}$

MODULE CHARACTERISTICS($T_C = 25^\circ C$ unless otherwise specified)

Symbol	Parameter/ Test Conditions	Values	Unit	
T_{Jmax}	Max. Junction Temperature	175	$^\circ C$	
T_{Jop}	Operating Temperature	-40~150		
T_{stg}	Storage Temperature	-40~125		
V_{isol}	Isolation Breakdown Voltage	2500	V	
CTI	Comparative Tracking Index	>200		
Torque	to heatsink	Recommended (M5)	3~5	Nm
	to terminal	Recommended (M6)	3~5	Nm
Weight		340	g	

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ELECTRICAL CHARACTERISTICS ($T_C = 25^\circ\text{C}$ unless otherwise specified)

Symbol	Parameter/ Test Conditions		Min.	Typ.	Max.	Unit	
$V_{GE(th)}$	Gate Emitter Threshold Voltage	$V_{CE}=V_{GE}, I_C=6\text{mA}$	5.4	5.9	6.5	V	
$V_{CE(sat)}$	Collector Emitter Saturation Voltage	$I_C=450\text{A}, V_{GE}=15\text{V}, T_J=25^\circ\text{C}$		1.65	2		
		$I_C=450\text{A}, V_{GE}=15\text{V}, T_J=125^\circ\text{C}$		1.95	2.35		
		$I_C=450\text{A}, V_{GE}=15\text{V}, T_J=150^\circ\text{C}$		2	2.4		
I_{CES}	Collector Leakage Current	$V_{CE}=1200\text{V}, V_{GE}=0\text{V}, T_J=25^\circ\text{C}$			1	mA	
		$V_{CE}=1200\text{V}, V_{GE}=0\text{V}, T_J=150^\circ\text{C}$			10	mA	
I_{GES}	Gate Leakage Current	$V_{CE}=0\text{V}, V_{GE}=\pm 20\text{V}, T_J=25^\circ\text{C}$			± 500	nA	
R_{gint}	Integrated Gate Resistor			1		Ω	
Q_g	Gate Charge	$V_{CE}=600\text{V}, I_C=450\text{A}, V_{GE}=15\text{V}$		4.6		μC	
C_{ies}	Input Capacitance	$V_{CE}=25\text{V}, V_{GE}=0\text{V}, f=1\text{MHz}$		62		nF	
C_{res}	Reverse Transfer Capacitance				0.82		pF
$t_{d(on)}$	Turn on Delay Time	$V_{CC}=600\text{V}, I_C=450\text{A}$ $R_G=1.5\Omega,$ $V_{GE}=\pm 15\text{V},$ Inductive Load	$T_J=25^\circ\text{C}$		220		ns
			$T_J=150^\circ\text{C}$		230		ns
t_r	Rise Time		$T_J=25^\circ\text{C}$		70		ns
			$T_J=150^\circ\text{C}$		80		ns
$t_{d(off)}$	Turn off Delay Time	$T_J=25^\circ\text{C}$		530		ns	
		$T_J=150^\circ\text{C}$		600		ns	
t_f	Fall Time	$T_J=25^\circ\text{C}$		260		ns	
		$T_J=150^\circ\text{C}$		330		ns	
E_{on}	Turn on Energy	$T_J=25^\circ\text{C}$		9		mJ	
		$T_J=150^\circ\text{C}$		15		mJ	
E_{off}	Turn off Energy	$T_J=25^\circ\text{C}$		55		mJ	
		$T_J=150^\circ\text{C}$		70		mJ	
I_{sc}	Short Circuit Current	$t_{psc}\leq 10\mu\text{S}, V_{GE}=15\text{V}$ $T_J=150^\circ\text{C}, V_{CC}=800\text{V}$		2300		A	
R_{thJC}	Junction to Case Thermal Resistance (Per IGBT)				0.052	K /W	

Diode-inverter

ELECTRICAL CHARACTERISTICS (T_C =25°C unless otherwise specified)

Symbol	Parameter/ Test Conditions	Min.	Typ.	Max.	Unit	
V _F	Collector Emitter Voltage	I _F =450A, V _{GE} =0V, T _J = 2 5 °C		1.65	2.05	V
		I _F =450A, V _{GE} =0V, T _J = 1 2 5 °C		1.75		
		I _F =450A, V _{GE} =0V, T _J = 1 5 0 °C		1.75		
T _{rr}	Gate Emitter Voltage		500		nS	
I _{RRM}	DC Collector Current	I _F =450A , V _R =600V di _F /dt=-4700A/μs T _J =150°C		365	A	
Q _{RR}	Repetitive Peak Collector Current			90	μC	
E _{rec}	Power Dissipation Per IGBT			27	mJ	
R _{thJCD}	Junctionto CaseThermal Resistance (Per Diode)			0.086	kW	

NTC CHARACTERISTICS (T_C=25°C unless otherwise specified)

Symbol	Parameter/ Test Conditions	Min.	Typ.	Max.	Unit
R ₂₅	Rated resistance	T _C = 2 5 °C		5	KΩ
ΔR/R	Deviation of R100	-5		5	%
P ₂₅	Power dissipation	T _C = 2 5 °C		20	mW
B _{25/50}	B-value	R ₂ = R ₂₅ exp [B _{25/50} (1/T ₂ -1/(298.15 K))]		3375	K

IGBT Typical Performance

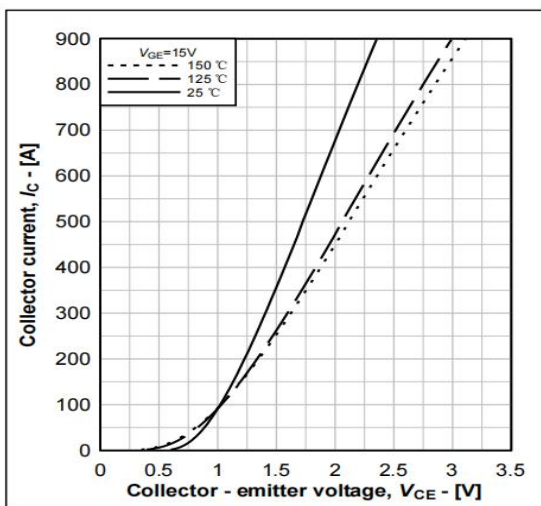


Figure1 Typical IGBT output characteristics

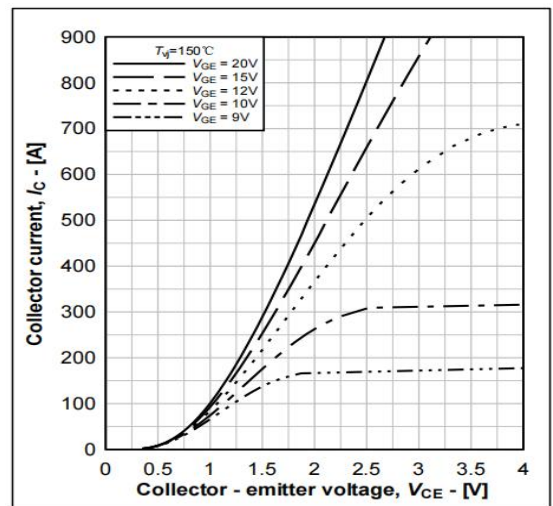


Figure2 Typical IGBT output characteristics

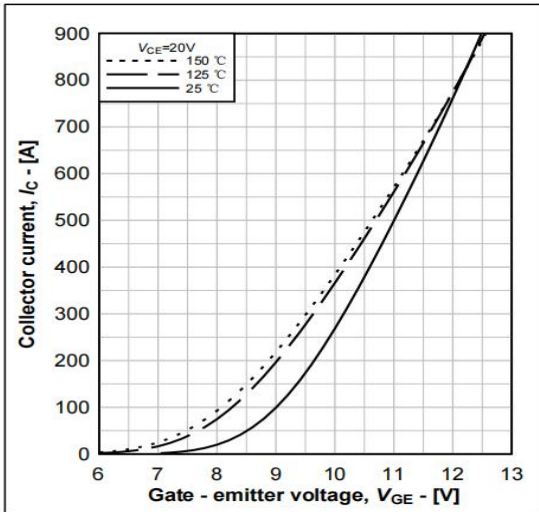


Figure3 Typical IGBT transfer characteristics

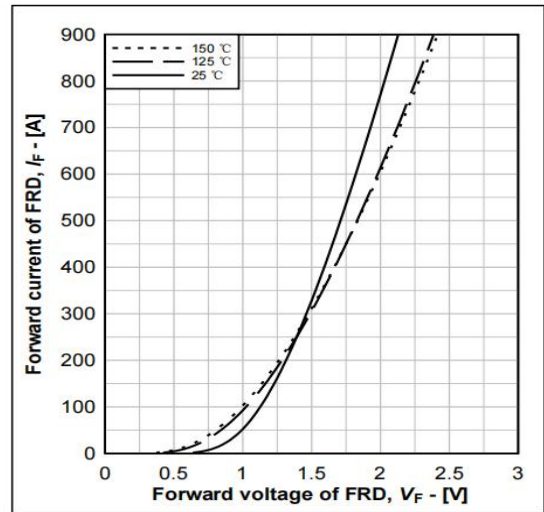


Figure4 Typical FRD output characteristics

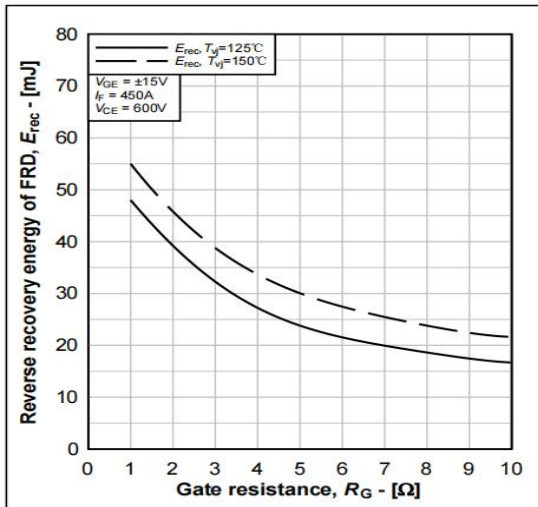


Figure5 Typical FRD Erec

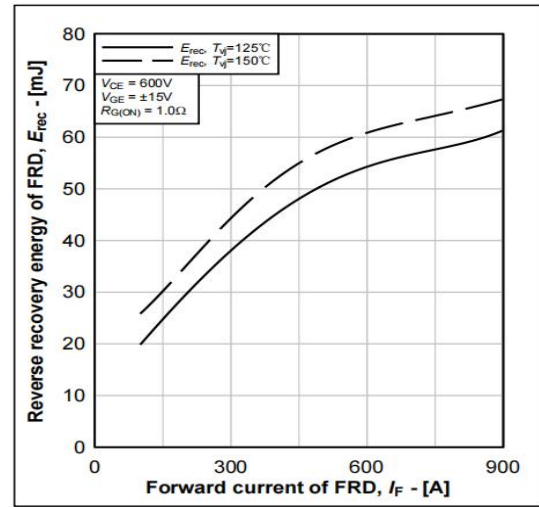


Figure6 Typical FRD Erec

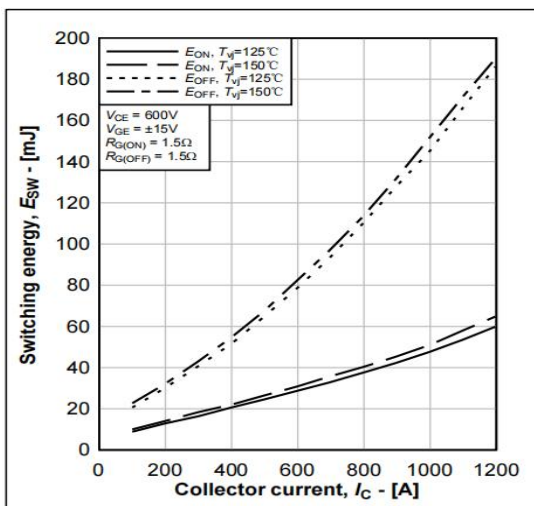


Figure7 Typical IGBT switching energy

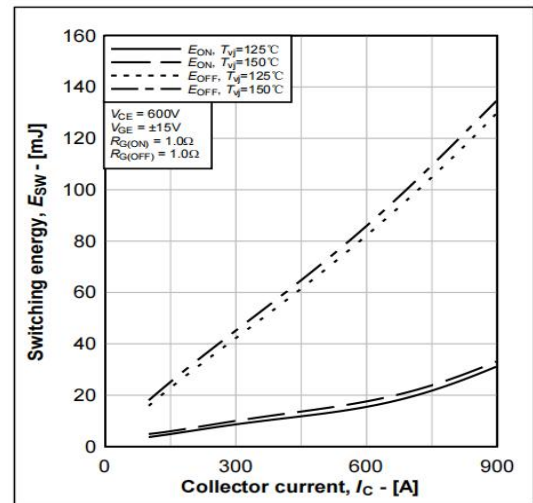


Figure8 Typical IGBT switching energy

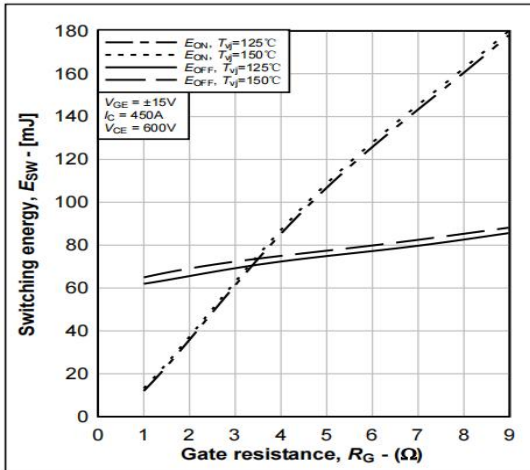


Figure9 Typical IGBT switching energy

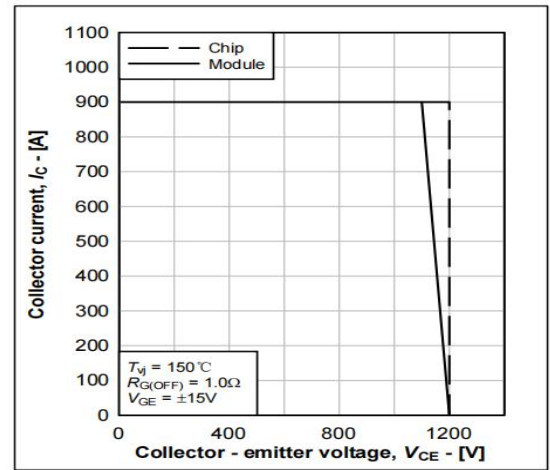


Figure10 Reverse bias safe operating area of IGBT

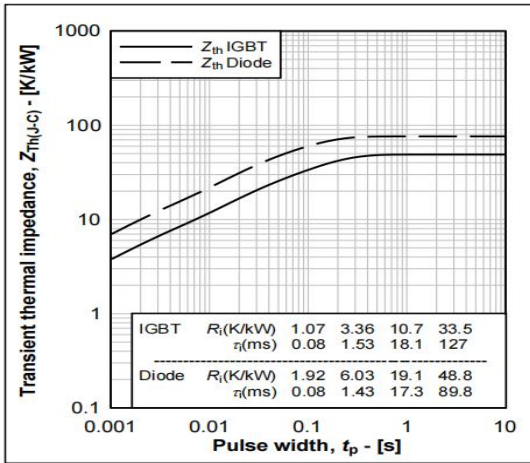


Figure11 Transient thermal impedance

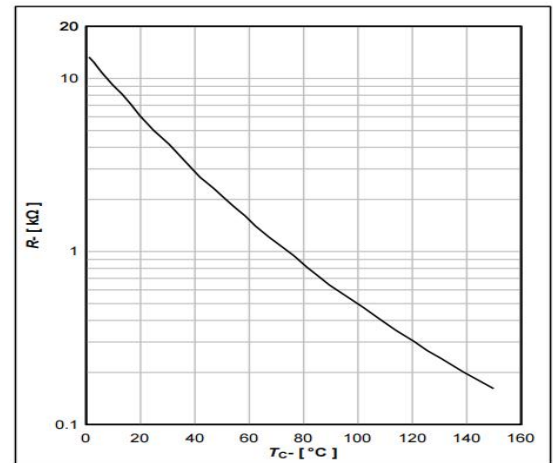
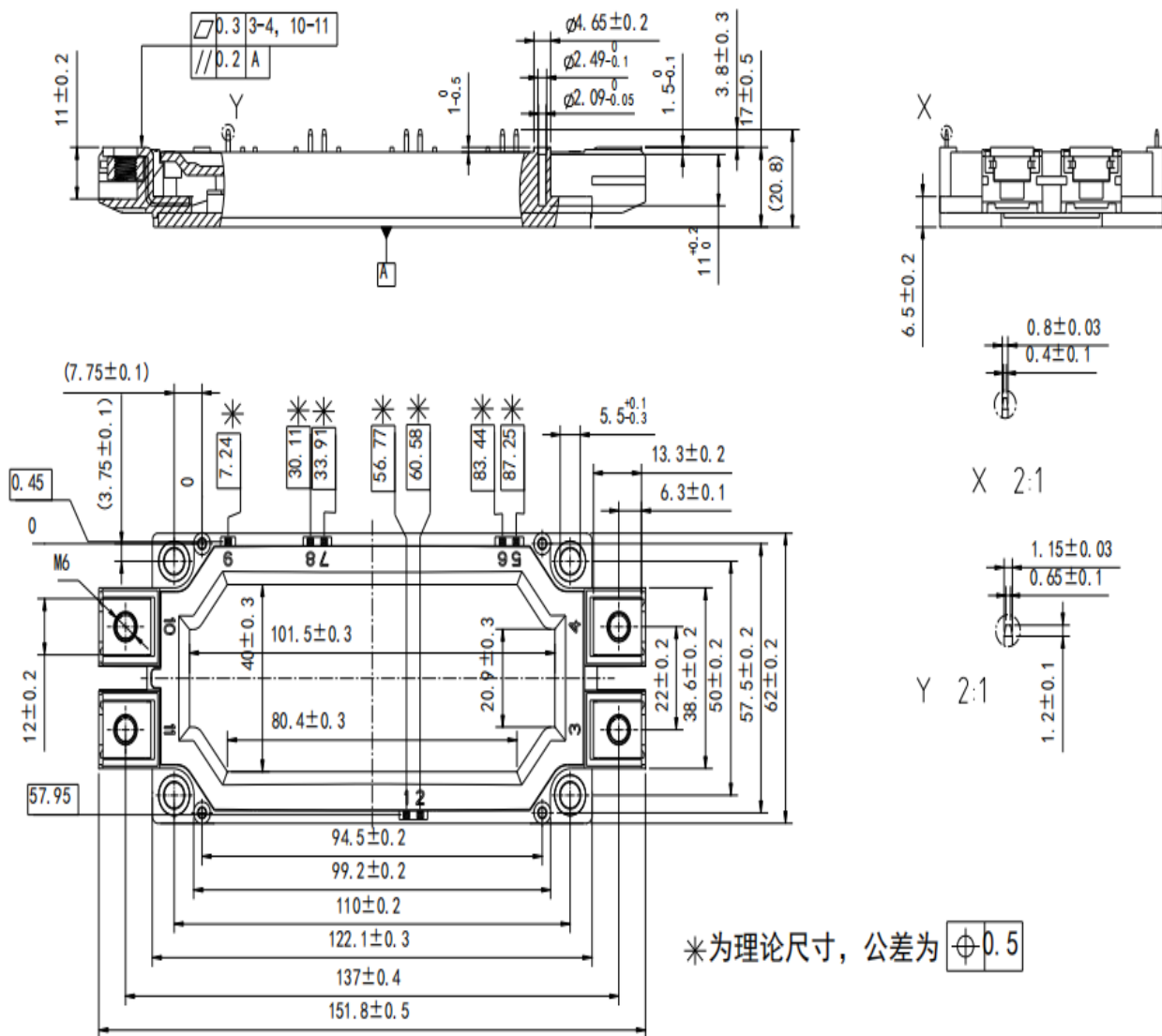


Figure12 Typical NTC thermistor characteristic

Package Dimensions: ED3



Dimensions in (mm)
Figure 13 Package Outline

深圳市安世益半导体有限公司

Shenzhen ANSEI Semiconductor Co., Ltd.

Add : #1903, Hengbo Center, No. 266 Jianshe Road, Longhua District, ShenzhenCity, Guangdong Province, P. R. of China

Post Code : 518000

TEL/FAX: 0755-28012916

战略代理[百硅] 0755-2307 3210